



IEEE HOME | SEARCH IEEE | SHOP | WEB ACCOUNT | CONTACT IEEE

Membership Publications/Services Standards Conferences Careers/Jobs

IEEE Xplore®
RELEASE 1.7

Help FAQ Terms IEEE Peer Review

Quick Links

» Advanced Search

Welcome to IEEE Xplore®

- Home
- What Can I Access?
- Log-out

Tables of Contents

- Journals & Magazines
- Conference Proceedings
- Standards

Search

- By Author
- Basic
- Advanced

Member Services

- Join IEEE
- Establish IEEE Web Account
- Access the IEEE Member Digital Library

- 1) Enter a single keyword, phrase, or Boolean expression. Example: acoustic imaging (means the phrase acoustic imaging plus any stem variations)
- 2) Limit your search by using search operators and field codes, if desired. Example: optical <and> (fiber <or> fibre) <in> ti
- 3) Limit the results by selecting Search Options.
- 4) Click Search. See [Search Examples](#)

vibration* and (simulat* or model*)
and test* and calibrat*

Note: This function returns plural and suffixed forms of the keyword(s).

Search operators: <and> <or> <not> <in> [More](#)

Field codes: au (author), ti (title), ab (abstract), jn (publication name), de (index term) [More](#)

Search Options:

Select publication types:

- IEEE Journals
- IEE Journals
- IEEE Conference proceedings
- IEE Conference proceedings
- IEEE Standards

Select years to search:

From year: to

Organize search results by:

Sort by:

In: order

List Results per page

[Home](#) | [Log-out](#) | [Journals](#) | [Conference Proceedings](#) | [Standards](#) | [Search by Author](#) | [Basic Search](#) | [Advanced Search](#) | [Join IEEE](#) | [Web Account](#)
 | [New this week](#) | [OPAC Linking Information](#) | [Your Feedback](#) | [Technical Support](#) | [Email Alerting](#) | [No Robots Please](#) | [Release Notes](#) | [IEEE Online Publications](#) | [Help](#) | [FAQ](#) | [Terms](#) | [Back to Top](#)

Copyright © 2004 IEEE — All rights reserved



IEEE HOME | SEARCH IEEE | SHOP | WEB ACCOUNT | CONTACT IEEE

Membership Publications/Services Standards Conferences Careers/Jobs



RELEASE 1.5

Help FAQ Terms IEEE Peer Review

Quick Links

» Search Results

Welcome to IEEE Xplore®

- Home
- What Can I Access?
- Log-out

Tables of Contents

- Journals & Magazines
- Conference Proceedings
- Standards

Search

- By Author
- Basic
- Advanced

Member Services

- Join IEEE
- Establish IEEE Web Account
- Access the IEEE Member Digital Library

Print Format

Your search matched **10** of **991126** documents.A maximum of **10** results are displayed, **50** to a page, sorted by **publication year in ascending order**.

You may refine your search by editing the current search expression or entering a new one in the text box.

Then click **Search Again**.

Results:

Journal or Magazine = **JNL** Conference = **CNF** Standard = **STD****1 Performances of the OVH magnetometer for the Danish Oersted satellite**

Duret, D.; Leger, J.M.; Frances, M.; Bonzom, J.; Alcouffe, F.; Perret, A.; Llorens, J.C.; Baby, C.;

Magnetics, IEEE Transactions on, Volume: 32 Issue: 5, Sept. 1996

Page(s): 4935 -4937

[\[Abstract\]](#) [\[PDF Full-Text \(360 KB\)\]](#) **IEEE JNL****2 Data acquisition of mechanical devices: a new way to think**

Head, M.;

AUTOTESTCON '98. IEEE Systems Readiness Technology Conference., 1998 IEEE , 24-27 Aug. 1998

Page(s): 479 -485

[\[Abstract\]](#) [\[PDF Full-Text \(652 KB\)\]](#) **IEEE CNF****3 SiMMA™ accelerometer for inertial guidance and navigation**

Leonardson, R.; Foote, S.;

Position Location and Navigation Symposium, IEEE 1998 , 20-23 April 1998

Page(s): 152 -160

[\[Abstract\]](#) [\[PDF Full-Text \(528 KB\)\]](#) **IEEE CNF****4 IEEE standard specification format guide and test procedure for linear, single-axis, nongyroscopic accelerometers**

IEEE Std 1293-1998 , 16 April 1999

[\[Abstract\]](#) [\[PDF Full-Text \(11992 KB\)\]](#) **IEEE STD**

5 Experimental and theoretical studies of PZT glide head vibration

Jin-Hui Ou-Yang; Tsay, A.Y.; Shen, I.Y.; Kuo, D.;

Magnetics, IEEE Transactions on, Volume: 35 Issue: 5, Sept. 1999

Page(s): 2493 -2495

[\[Abstract\]](#) [\[PDF Full-Text \(200 KB\)\]](#) **IEEE JNL**

6 Durability/reliability of BGA solder joints under vibration environment

Wong, T.E.; Palmieri, F.W.; Reed, B.A.; Fenger, H.S.; Cohen, H.M.; Teshiba, K.T.;

Electronic Components and Technology Conference, 2000. 2000 Proceedings.

50th, 21-24 May 2000

Page(s): 1083 -1088

[\[Abstract\]](#) [\[PDF Full-Text \(584 KB\)\]](#) **IEEE CNF**

7 Infrared diode laser absorption spectroscopic characterization of the free-stream in the f4 wind tunnel

Mohamed, A.K.; Verant, J.-L.; Soutade, J.;

Instrumentation in Aerospace Simulation Facilities, 2001. 19th International Congress on ICIASF 2001, 27-30 Aug. 2001

Page(s): 302 -308

[\[Abstract\]](#) [\[PDF Full-Text \(520 KB\)\]](#) **IEEE CNF**

8 Applying MEMS technology to field, flight and space deployable systems

Shams, Q.A.; Moniuszko, M.; Ingham, J.C.;

Instrumentation in Aerospace Simulation Facilities, 2001. 19th International Congress on ICIASF 2001, 27-30 Aug. 2001

Page(s): 246 -255

[\[Abstract\]](#) [\[PDF Full-Text \(816 KB\)\]](#) **IEEE CNF**

9 Enhancement of physics-of-failure prognostic models with system level features

Kacprzynski, G.J.; Roemer, M.J.; Modgil, G.; Palladino, A.; Maynard, K.;

Aerospace Conference Proceedings, 2002. IEEE, Volume: 6, 9-16 March 2002

Page(s): 6-2919 -6-2925 vol.6

[\[Abstract\]](#) [\[PDF Full-Text \(686 KB\)\]](#) **IEEE CNF**

10 Under-filled BGA solder joint vibration fatigue damage

Wong, T.E.; Palmieri, F.W.; Fenger, H.S.;

Thermal and Thermomechanical Phenomena in Electronic Systems, 2002.

ITHERM 2002. The Eighth Intersociety Conference on, 30 May-1 June 2002

Page(s): 961 -966

[\[Abstract\]](#) [\[PDF Full-Text \(588 KB\)\]](#) **IEEE CNF**

[Home](#) | [Log-out](#) | [Journals](#) | [Conference Proceedings](#) | [Standards](#) | [Search by Author](#) | [Basic Search](#) | [Advanced Search](#)
[Join IEEE](#) | [Web Account](#) | [New this week](#) | [OPAC Linking Information](#) | [Your Feedback](#) | [Technical Support](#) | [Email Alerting](#)
[No Robots Please](#) | [Release Notes](#) | [IEEE Online Publications](#) | [Help](#) | [FAQ](#) | [Terms](#) | [Back to Top](#)

Copyright © 2003 IEEE — All rights reserved